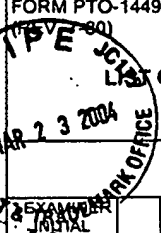



FORM PTO-1449 (REV. 7-80)		U.S. DEPARTMENT OF COMMERCE PATENT & TRADEMARK OFFICE		ATTY. DOCKET NO. NIT-163-02	SERIAL NO. 10/075,283			
LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT M. IWAYAMA et al				
				FILING DATE February 15, 2002				
				GROUP 21642165				
U.S. PATENT DOCUMENTS								
* EXAMINER INITIAL		DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)	
	AA							
	AB							
	AC							
	AD							
	AE							
	AF							
	AG							
	AH							
	AI							
	AJ							
	AK							
FOREIGN PATENT DOCUMENTS								
		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
NAD	AL	9-218881	08/1997	JAPAN			<input checked="" type="checkbox"/>	<input type="checkbox"/>
WAG	AM	4-138563	05/1992	JAPAN			<input checked="" type="checkbox"/>	<input type="checkbox"/>
	AN						<input type="checkbox"/>	<input type="checkbox"/>
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)								
WAG WAG	AR	"Dynamic Co-occurrence Analysis for Interactive Document Retrieval", by Yoshiki Niwa, Advanced Research Laboratory, Hitachi, Ltd., pgs. 41-48 (including English-Language Translated Abstract). <i>no Date</i>						
		"Searching, Browsing, and Metasearching with SenseMaker - Seek and Ye Shall Find", by Michelle Q. Wang Baldonado, New Architect Internet Strategies for Technology Leaders, pgs. 31-36, (including English-language Translated Abstract pgs. 1-4). <i>no Date</i>						
	AS							
	AT							
EXAMINER <i>James</i>				DATE CONSIDERED <i>7/25/05</i>				
* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 608; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								

FORM PTO-1449 (Rev. 8-01)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. NIT-163-02		SERIAL NO. 10/075,283	
 LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT M. IWAYAMA et al		GROUP 2175 2165	
				FILING DATE February 15, 2002			
U.S. PATENT DOCUMENTS							
		DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)
MAJ	AA	5,590,319	12/31/96	Cohen et al			
MAJ	AB	5,987,460	11/1999	Niwa et al			
NAD	AC	5,926,811	07/1999	Miller et al			
NAD	AD	5,870,740	02/1999	Miller et al			
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
NAD	AL	64-74210	03/20/89	Japan			<input type="checkbox"/> <input type="checkbox"/>
NAD	AM	93/37499	08/27/98	WO PCT			<input type="checkbox"/> <input type="checkbox"/>
NAD	AN	10-74210	03/17/98	Japanese Laid-Open Patent			<input type="checkbox"/> <input type="checkbox"/>
NAD	AO	11-85786	03/30/99	Japanese Laid-Open Patent			<input type="checkbox"/> <input type="checkbox"/>
NAD	AP	10-254887	09/25/98	Japanese Laid-Open Patent			<input type="checkbox"/> <input type="checkbox"/>
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)							
NAD	AR	B. Velez et al, "Fast and Effective Query Refinement", Annual International ACM-SIGIR Conference on Research and Development in Information Retrieval, US, New York, NY, July 27, 1997, pp. 6-15.					
	AS						
	AT						
EXAMINER 				DATE CONSIDERED 7/25/05			

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FORM PTO-1449 (REV. 7-80)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. NIT-163-02	SERIAL NO. 10/075,283
LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)		APPLICANT M. IWAYAMA et al	GROUP 2175-2165
		FILING DATE February 15, 2002	

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT	DATE	NAME	CLASS	SUBCLASS	FILING DATE (If Appropriate)
	AA					
	AB					
	AC					
	AD					
	AE					
	AF					
	AG					
	AH					
	AI					
	AJ					
	AK					

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FOREIGN PATENT DOCUMENTS

	DOCUMENT	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO
MB	AL 8-287103	11/01/96	Japanese Laid-Open Patent			<input type="checkbox"/>	<input type="checkbox"/>
NPO	AM 9-62693	03/07/97	Japanese Laid-Open Patent			<input type="checkbox"/>	<input type="checkbox"/>
	AN					<input type="checkbox"/>	<input type="checkbox"/>
	AO					<input type="checkbox"/>	<input type="checkbox"/>
	AP					<input type="checkbox"/>	<input type="checkbox"/>

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

AR	
AS	
AT	

EXAMINER <i>[Signature]</i>	DATE CONSIDERED 7/25/05
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